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### **Understanding Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### **Details**

Product Status	Obsolete
Number of LABs/CLBs	1152
Number of Logic Elements/Cells	11520
Total RAM Bits	147456
Number of I/O	152
Number of Gates	728000
Voltage - Supply	1.71V ~ 1.89V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	240-BFQFP
Supplier Device Package	240-PQFP (32x32)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/intel/ep20k300eqi240-3">https://www.e-xfl.com/product-detail/intel/ep20k300eqi240-3</a>

**Table 5. APEX 20K FineLine BGA Package Options & I/O Count** *Notes (1), (2)*

<b>Device</b>	<b>144 Pin</b>	<b>324 Pin</b>	<b>484 Pin</b>	<b>672 Pin</b>	<b>1,020 Pin</b>
EP20K30E	93	128			
EP20K60E	93	196			
EP20K100		252			
EP20K100E	93	246			
EP20K160E			316		
EP20K200			382		
EP20K200E			376	376	
EP20K300E				408	
EP20K400				502 (3)	
EP20K400E				488 (3)	
EP20K600E				508 (3)	588
EP20K1000E				508 (3)	708
EP20K1500E					808

**Notes to Tables 4 and 5:**

- (1) I/O counts include dedicated input and clock pins.
- (2) APEX 20K device package types include thin quad flat pack (TQFP), plastic quad flat pack (PQFP), power quad flat pack (RQFP), 1.27-mm pitch ball-grid array (BGA), 1.00-mm pitch FineLine BGA, and pin-grid array (PGA) packages.
- (3) This device uses a thermally enhanced package, which is taller than the regular package. Consult the *Altera Device Package Information Data Sheet* for detailed package size information.

**Table 6. APEX 20K QFP, BGA & PGA Package Sizes**

<b>Feature</b>	<b>144-Pin TQFP</b>	<b>208-Pin QFP</b>	<b>240-Pin QFP</b>	<b>356-Pin BGA</b>	<b>652-Pin BGA</b>	<b>655-Pin PGA</b>
Pitch (mm)	0.50	0.50	0.50	1.27	1.27	—
Area (mm <sup>2</sup> )	484	924	1,218	1,225	2,025	3,906
Length × Width (mm × mm)	22 × 22	30.4 × 30.4	34.9 × 34.9	35 × 35	45 × 45	62.5 × 62.5

**Table 7. APEX 20K FineLine BGA Package Sizes**

<b>Feature</b>	<b>144 Pin</b>	<b>324 Pin</b>	<b>484 Pin</b>	<b>672 Pin</b>	<b>1,020 Pin</b>
Pitch (mm)	1.00	1.00	1.00	1.00	1.00
Area (mm <sup>2</sup> )	169	361	529	729	1,089
Length × Width (mm × mm)	13 × 13	19 × 19	23 × 23	27 × 27	33 × 33

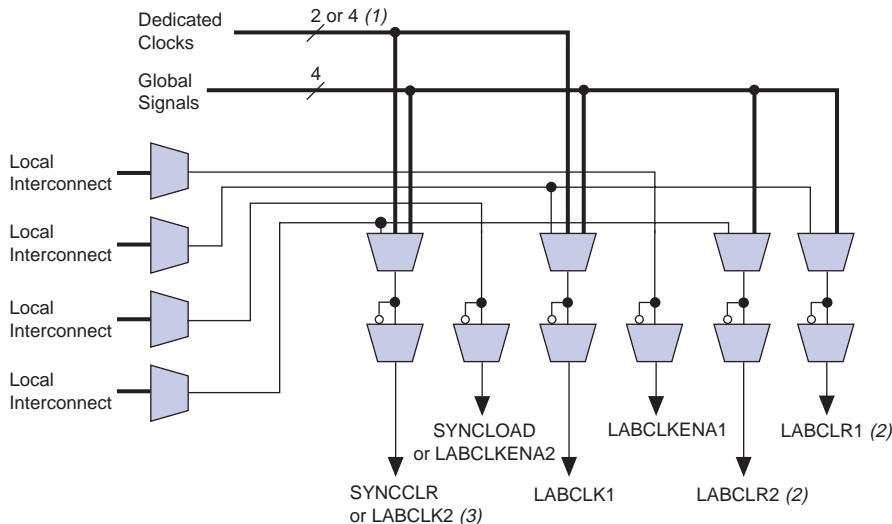
Each LAB contains dedicated logic for driving control signals to its LEs and ESBs. The control signals include clock, clock enable, asynchronous clear, asynchronous preset, asynchronous load, synchronous clear, and synchronous load signals. A maximum of six control signals can be used at a time. Although synchronous load and clear signals are generally used when implementing counters, they can also be used with other functions.

Each LAB can use two clocks and two clock enable signals. Each LAB's clock and clock enable signals are linked (e.g., any LE in a particular LAB using CLK1 will also use CLKENA1). LEs with the same clock but different clock enable signals either use both clock signals in one LAB or are placed into separate LABs.

If both the rising and falling edges of a clock are used in a LAB, both LAB-wide clock signals are used.

The LAB-wide control signals can be generated from the LAB local interconnect, global signals, and dedicated clock pins. The inherent low skew of the FastTrack Interconnect enables it to be used for clock distribution. [Figure 4](#) shows the LAB control signal generation circuit.

**Figure 4. LAB Control Signal Generation**



**Notes to Figure 4:**

- (1) APEX 20KE devices have four dedicated clocks.
- (2) The LABCLR1 and LABCLR2 signals also control asynchronous load and asynchronous preset for LEs within the LAB.
- (3) The SYNCCLR signal can be generated by the local interconnect or global signals.

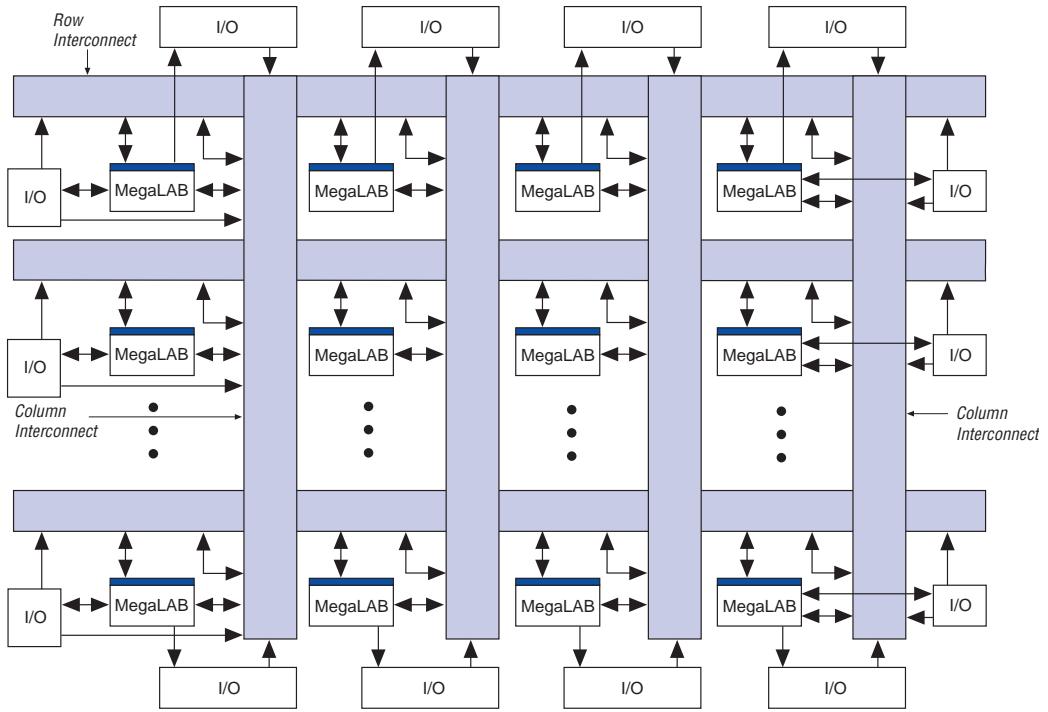
### *LE Operating Modes*

The APEX 20K LE can operate in one of the following three modes:

- Normal mode
- Arithmetic mode
- Counter mode

Each mode uses LE resources differently. In each mode, seven available inputs to the LE—the four data inputs from the LAB local interconnect, the feedback from the programmable register, and the carry-in and cascade-in from the previous LE—are directed to different destinations to implement the desired logic function. LAB-wide signals provide clock, asynchronous clear, asynchronous preset, asynchronous load, synchronous clear, synchronous load, and clock enable control for the register. These LAB-wide signals are available in all LE modes.

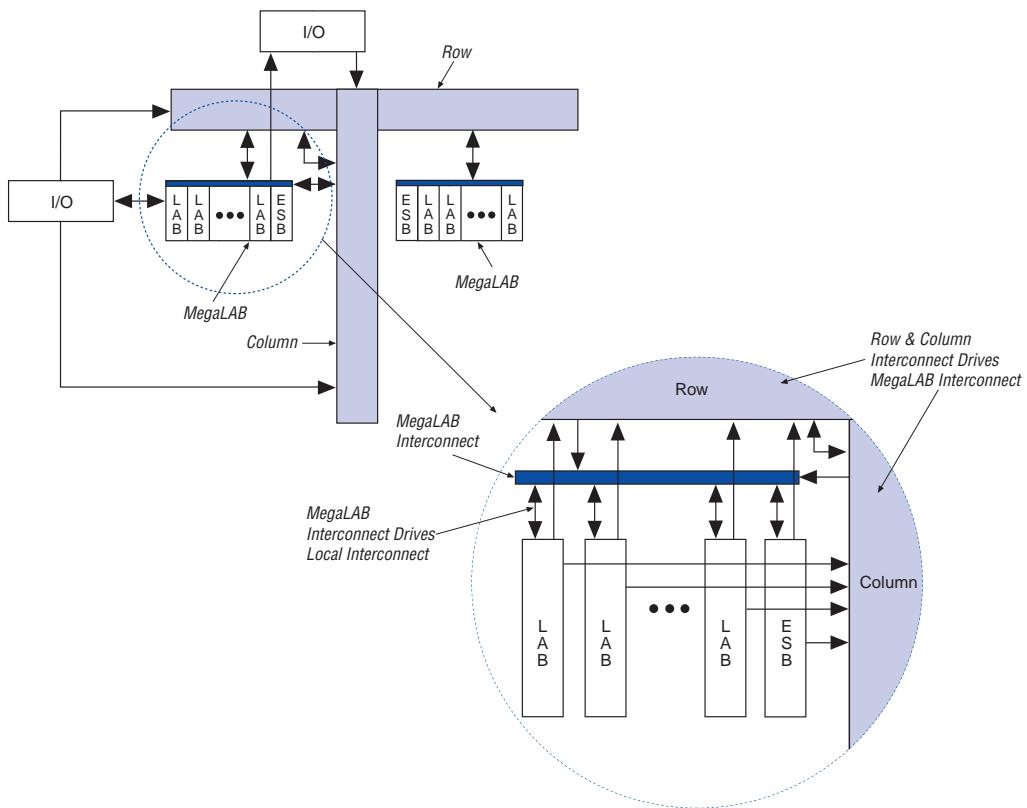
The Quartus II software, in conjunction with parameterized functions such as LPM and DesignWare functions, automatically chooses the appropriate mode for common functions such as counters, adders, and multipliers. If required, the designer can also create special-purpose functions that specify which LE operating mode to use for optimal performance. [Figure 8](#) shows the LE operating modes.

**Figure 9. APEX 20K Interconnect Structure**

A row line can be driven directly by LEs, IOEs, or ESBs in that row. Further, a column line can drive a row line, allowing an LE, IOE, or ESB to drive elements in a different row via the column and row interconnect. The row interconnect drives the MegaLAB interconnect to drive LEs, IOEs, or ESBs in a particular MegaLAB structure.

A column line can be directly driven by LEs, IOEs, or ESBs in that column. A column line on a device's left or right edge can also be driven by row IOEs. The column line is used to route signals from one row to another. A column line can drive a row line; it can also drive the MegaLAB interconnect directly, allowing faster connections between rows.

[Figure 10](#) shows how the FastTrack Interconnect uses the local interconnect to drive LEs within MegaLAB structures.

**Figure 10. FastTrack Connection to Local Interconnect**

**Figure 23. APEX 20KE CAM Block Diagram**

CAM can be used in any application requiring high-speed searches, such as networking, communications, data compression, and cache management.

The APEX 20KE on-chip CAM provides faster system performance than traditional discrete CAM. Integrating CAM and logic into the APEX 20KE device eliminates off-chip and on-chip delays, improving system performance.

When in CAM mode, the ESB implements 32-word, 32-bit CAM. Wider or deeper CAM can be implemented by combining multiple CAMs with some ancillary logic implemented in LEs. The Quartus II software combines ESBs and LEs automatically to create larger CAMs.

CAM supports writing “don’t care” bits into words of the memory. The “don’t-care” bit can be used as a mask for CAM comparisons; any bit set to “don’t-care” has no effect on matches.

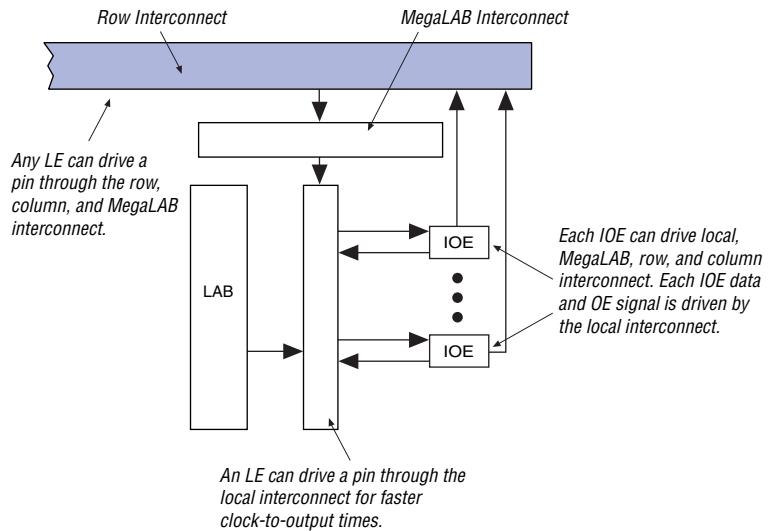
The output of the CAM can be encoded or unencoded. When encoded, the ESB outputs an encoded address of the data’s location. For instance, if the data is located in address 12, the ESB output is 12. When unencoded, the ESB uses its 16 outputs to show the location of the data over two clock cycles. In this case, if the data is located in address 12, the 12th output line goes high. When using unencoded outputs, two clock cycles are required to read the output because a 16-bit output bus is used to show the status of 32 words.

The encoded output is better suited for designs that ensure duplicate data is not written into the CAM. If duplicate data is written into two locations, the CAM’s output will be incorrect. If the CAM may contain duplicate data, the unencoded output is a better solution; CAM with unencoded outputs can distinguish multiple data locations.

CAM can be pre-loaded with data during configuration, or it can be written during system operation. In most cases, two clock cycles are required to write each word into CAM. When “don’t-care” bits are used, a third clock cycle is required.

Each IOE drives a row, column, MegaLAB, or local interconnect when used as an input or bidirectional pin. A row IOE can drive a local, MegaLAB, row, and column interconnect; a column IOE can drive the column interconnect. [Figure 27](#) shows how a row IOE connects to the interconnect.

**Figure 27. Row IOE Connection to the Interconnect**



**Table 24. APEX 20K 5.0-V Tolerant Device Recommended Operating Conditions Note (2)**

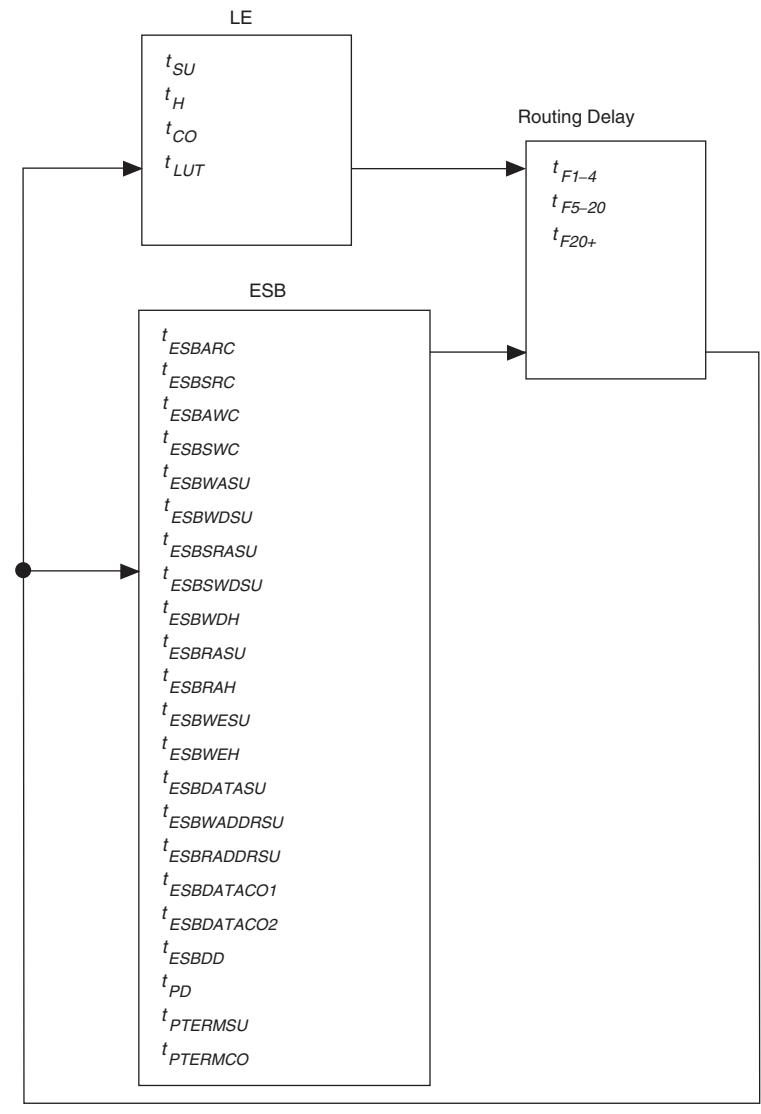
<b>Symbol</b>	<b>Parameter</b>	<b>Conditions</b>	<b>Min</b>	<b>Max</b>	<b>Unit</b>
$V_{CCINT}$	Supply voltage for internal logic and input buffers	(4), (5)	2.375 (2.375)	2.625 (2.625)	V
$V_{CCIO}$	Supply voltage for output buffers, 3.3-V operation	(4), (5)	3.00 (3.00)	3.60 (3.60)	V
	Supply voltage for output buffers, 2.5-V operation	(4), (5)	2.375 (2.375)	2.625 (2.625)	V
$V_I$	Input voltage	(3), (6)	-0.5	5.75	V
$V_O$	Output voltage		0	$V_{CCIO}$	V
$T_J$	Junction temperature	For commercial use	0	85	°C
		For industrial use	-40	100	°C
$t_R$	Input rise time			40	ns
$t_F$	Input fall time			40	ns

**Table 25. APEX 20K 5.0-V Tolerant Device DC Operating Conditions (Part 1 of 2) Notes (2), (7), (8)**

<b>Symbol</b>	<b>Parameter</b>	<b>Conditions</b>	<b>Min</b>	<b>Typ</b>	<b>Max</b>	<b>Unit</b>
$V_{IH}$	High-level input voltage		1.7, 0.5 × $V_{CCIO}$ (9)		5.75	V
$V_{IL}$	Low-level input voltage		-0.5		0.8, 0.3 × $V_{CCIO}$ (9)	V
$V_{OH}$	3.3-V high-level TTL output voltage	$I_{OH} = -8 \text{ mA DC}$ , $V_{CCIO} = 3.00 \text{ V}$ (10)	2.4			V
	3.3-V high-level CMOS output voltage	$I_{OH} = -0.1 \text{ mA DC}$ , $V_{CCIO} = 3.00 \text{ V}$ (10)	$V_{CCIO} - 0.2$			V
	3.3-V high-level PCI output voltage	$I_{OH} = -0.5 \text{ mA DC}$ , $V_{CCIO} = 3.00 \text{ to } 3.60 \text{ V}$ (10)	$0.9 \times V_{CCIO}$			V
	2.5-V high-level output voltage	$I_{OH} = -0.1 \text{ mA DC}$ , $V_{CCIO} = 2.30 \text{ V}$ (10)	2.1			V
		$I_{OH} = -1 \text{ mA DC}$ , $V_{CCIO} = 2.30 \text{ V}$ (10)	2.0			V
		$I_{OH} = -2 \text{ mA DC}$ , $V_{CCIO} = 2.30 \text{ V}$ (10)	1.7			V

**Table 25. APEX 20K 5.0-V Tolerant Device DC Operating Conditions (Part 2 of 2) Notes (2), (7), (8)**

<b>Symbol</b>	<b>Parameter</b>	<b>Conditions</b>	<b>Min</b>	<b>Typ</b>	<b>Max</b>	<b>Unit</b>
$V_{OL}$	3.3-V low-level TTL output voltage	$I_{OL} = 12 \text{ mA DC}$ , $V_{CCIO} = 3.00 \text{ V}$ (11)			0.45	V
	3.3-V low-level CMOS output voltage	$I_{OL} = 0.1 \text{ mA DC}$ , $V_{CCIO} = 3.00 \text{ V}$ (11)			0.2	V
	3.3-V low-level PCI output voltage	$I_{OL} = 1.5 \text{ mA DC}$ , $V_{CCIO} = 3.00 \text{ to } 3.60 \text{ V}$ (11)			$0.1 \times V_{CCIO}$	V
	2.5-V low-level output voltage	$I_{OL} = 0.1 \text{ mA DC}$ , $V_{CCIO} = 2.30 \text{ V}$ (11)			0.2	V
		$I_{OL} = 1 \text{ mA DC}$ , $V_{CCIO} = 2.30 \text{ V}$ (11)			0.4	V
		$I_{OL} = 2 \text{ mA DC}$ , $V_{CCIO} = 2.30 \text{ V}$ (11)			0.7	V
$I_I$	Input pin leakage current	$V_I = 5.75 \text{ to } -0.5 \text{ V}$	-10		10	$\mu\text{A}$
$I_{IOZ}$	Tri-stated I/O pin leakage current	$V_O = 5.75 \text{ to } -0.5 \text{ V}$	-10		10	$\mu\text{A}$
$I_{CC0}$	V <sub>CC</sub> supply current (standby) (All ESBs in power-down mode)	$V_I = \text{ground, no load, no}$ toggling inputs, -1 speed grade (12)		10		mA
		$V_I = \text{ground, no load, no}$ toggling inputs, -2, -3 speed grades (12)		5		mA
$R_{CONF}$	Value of I/O pin pull-up resistor before and during configuration	$V_{CCIO} = 3.0 \text{ V}$ (13)	20		50	W
		$V_{CCIO} = 2.375 \text{ V}$ (13)	30		80	W

**Figure 37. APEX 20KE  $f_{MAX}$  Timing Model**

**Table 31. APEX 20K  $f_{MAX}$  Timing Parameters (Part 2 of 2)**

Symbol	Parameter
$t_{ESBDA}CO_2$	ESB clock-to-output delay without output registers
$t_{ESBDD}$	ESB data-in to data-out delay for RAM mode
$t_{PD}$	ESB macrocell input to non-registered output
$t_{PTERMSU}$	ESB macrocell register setup time before clock
$t_{PTERMCO}$	ESB macrocell register clock-to-output delay
$t_{F1-4}$	Fanout delay using local interconnect
$t_{F5-20}$	Fanout delay using MegaLab Interconnect
$t_{F20+}$	Fanout delay using FastTrack Interconnect
$t_{CH}$	Minimum clock high time from clock pin
$t_{CL}$	Minimum clock low time from clock pin
$t_{CLR}$	LE clear pulse width
$t_{PREP}$	LE preset pulse width
$t_{ESBCH}$	Clock high time
$t_{ESBCL}$	Clock low time
$t_{ESBWP}$	Write pulse width
$t_{ESBRP}$	Read pulse width

Tables 32 and 33 describe APEX 20K external timing parameters.

**Table 32. APEX 20K External Timing Parameters Note (1)**

Symbol	Clock Parameter
$t_{INSU}$	Setup time with global clock at IOE register
$t_{INH}$	Hold time with global clock at IOE register
$t_{OUTCO}$	Clock-to-output delay with global clock at IOE register

**Table 33. APEX 20K External Bidirectional Timing Parameters Note (1)**

Symbol	Parameter	Conditions
$t_{INSUBIDIR}$	Setup time for bidirectional pins with global clock at same-row or same-column LE register	
$t_{INHBIDIR}$	Hold time for bidirectional pins with global clock at same-row or same-column LE register	
$t_{OUTCOBIDIR}$	Clock-to-output delay for bidirectional pins with global clock at IOE register	$C_1 = 10 \text{ pF}$
$t_{ZXBIDIR}$	Synchronous IOE output buffer disable delay	$C_1 = 10 \text{ pF}$
$t_{ZXBIDIR}$	Synchronous IOE output buffer enable delay, slow slew rate = off	$C_1 = 10 \text{ pF}$

**Note to Tables 32 and 33:**

(1) These timing parameters are sample-tested only.

Tables 34 through 37 show APEX 20KE LE, ESB, routing, and functional timing microparameters for the  $f_{MAX}$  timing model.

**Table 34. APEX 20KE LE Timing Microparameters**

Symbol	Parameter
$t_{SU}$	LE register setup time before clock
$t_H$	LE register hold time after clock
$t_{CO}$	LE register clock-to-output delay
$t_{LUT}$	LUT delay for data-in to data-out

**Table 35. APEX 20KE ESB Timing Microparameters**

Symbol	Parameter
$t_{ESBARC}$	ESB Asynchronous read cycle time
$t_{ESBSRC}$	ESB Synchronous read cycle time
$t_{ESBAWC}$	ESB Asynchronous write cycle time
$t_{ESBSWC}$	ESB Synchronous write cycle time
$t_{ESBWASU}$	ESB write address setup time with respect to WE
$t_{ESBWAH}$	ESB write address hold time with respect to WE
$t_{ESBWDSU}$	ESB data setup time with respect to WE
$t_{ESBWDH}$	ESB data hold time with respect to WE
$t_{ESBRASU}$	ESB read address setup time with respect to RE
$t_{ESBRAH}$	ESB read address hold time with respect to RE
$t_{ESBWESU}$	ESB WE setup time before clock when using input register
$t_{ESBWEH}$	ESB WE hold time after clock when using input register
$t_{ESBDATASU}$	ESB data setup time before clock when using input register
$t_{ESBDATAH}$	ESB data hold time after clock when using input register
$t_{ESBWADDRSU}$	ESB write address setup time before clock when using input registers
$t_{ESBRAADDRSU}$	ESB read address setup time before clock when using input registers
$t_{ESBDATACO1}$	ESB clock-to-output delay when using output registers
$t_{ESBDATACO2}$	ESB clock-to-output delay without output registers
$t_{ESBDD}$	ESB data-in to data-out delay for RAM mode
$t_{PD}$	ESB Macrocell input to non-registered output
$t_{PTERMSU}$	ESB Macrocell register setup time before clock
$t_{PTERMCO}$	ESB Macrocell register clock-to-output delay

**Table 39. APEX 20KE External Bidirectional Timing Parameters** *Note (1)*

Symbol	Parameter	Conditions
$t_{INSUBIDIR}$	Setup time for bidirectional pins with global clock at LAB adjacent Input Register	
$t_{INHBIDIR}$	Hold time for bidirectional pins with global clock at LAB adjacent Input Register	
$t_{OUTCOBIDIR}$	Clock-to-output delay for bidirectional pins with global clock at IOE output register	$C_1 = 10 \text{ pF}$
$t_{XZBIDIR}$	Synchronous Output Enable Register to output buffer disable delay	$C_1 = 10 \text{ pF}$
$t_{ZXBIDIR}$	Synchronous Output Enable Register output buffer enable delay	$C_1 = 10 \text{ pF}$
$t_{INSUBDIRPLL}$	Setup time for bidirectional pins with PLL clock at LAB adjacent Input Register	
$t_{INHBIDIRPLL}$	Hold time for bidirectional pins with PLL clock at LAB adjacent Input Register	
$t_{OUTCOBIDIRPLL}$	Clock-to-output delay for bidirectional pins with PLL clock at IOE output register	$C_1 = 10 \text{ pF}$
$t_{XZBIDIRPLL}$	Synchronous Output Enable Register to output buffer disable delay with PLL	$C_1 = 10 \text{ pF}$
$t_{ZXBIDIRPLL}$	Synchronous Output Enable Register output buffer enable delay with PLL	$C_1 = 10 \text{ pF}$

*Note to Tables 38 and 39:*

- (1) These timing parameters are sample-tested only.

Tables 40 through 42 show the  $f_{MAX}$  timing parameters for EP20K100, EP20K200, and EP20K400 APEX 20K devices.

**Table 40. EP20K100  $f_{MAX}$  Timing Parameters**

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Units
	Min	Max	Min	Max	Min	Max	
$t_{SU}$	0.5		0.6		0.8		ns
$t_H$	0.7		0.8		1.0		ns
$t_{CO}$		0.3		0.4		0.5	ns
$t_{LUT}$		0.8		1.0		1.3	ns
$t_{ESBRC}$		1.7		2.1		2.4	ns
$t_{ESBWC}$		5.7		6.9		8.1	ns
$t_{ESBWESU}$	3.3		3.9		4.6		ns
$t_{ESBDATASU}$	2.2		2.7		3.1		ns
$t_{ESBDATAH}$	0.6		0.8		0.9		ns
$t_{ESBADDRSU}$	2.4		2.9		3.3		ns
$t_{ESBDATACO1}$		1.3		1.6		1.8	ns
$t_{ESBDATACO2}$		2.6		3.1		3.6	ns
$t_{ESBDD}$		2.5		3.3		3.6	ns
$t_{PD}$		2.5		3.0		3.6	ns
$t_{PTERMSU}$	2.3		2.6		3.2		ns
$t_{PTERMCO}$		1.5		1.8		2.1	ns
$t_{F1-4}$		0.5		0.6		0.7	ns
$t_{F5-20}$		1.6		1.7		1.8	ns
$t_{F20+}$		2.2		2.2		2.3	ns
$t_{CH}$	2.0		2.5		3.0		ns
$t_{CL}$	2.0		2.5		3.0		ns
$t_{CLRP}$	0.3		0.4		0.4		ns
$t_{PREP}$	0.5		0.5		0.5		ns
$t_{ESBCH}$	2.0		2.5		3.0		ns
$t_{ESBCL}$	2.0		2.5		3.0		ns
$t_{ESBWP}$	1.6		1.9		2.2		ns
$t_{ESBRP}$	1.0		1.3		1.4		ns

**Notes to Tables 43 through 48:**

- (1) This parameter is measured without using ClockLock or ClockBoost circuits.  
 (2) This parameter is measured using ClockLock or ClockBoost circuits.

**Tables 49 through 54** describe  $f_{MAX}$  LE Timing Microparameters,  $f_{MAX}$  ESB Timing Microparameters,  $f_{MAX}$  Routing Delays, Minimum Pulse Width Timing Parameters, External Timing Parameters, and External Bidirectional Timing Parameters for EP20K30E APEX 20KE devices.

**Table 49. EP20K30E  $f_{MAX}$  LE Timing Microparameters**

Symbol	-1		-2		-3		Unit
	Min	Max	Min	Max	Min	Max	
$t_{SU}$	0.01		0.02		0.02		ns
$t_H$	0.11		0.16		0.23		ns
$t_{CO}$		0.32		0.45		0.67	ns
$t_{LUT}$		0.85		1.20		1.77	ns

**Table 50. EP20K30E  $f_{MAX}$  ESB Timing Microparameters**

Symbol	-1		-2		-3		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>ESBARC</sub>		2.03		2.86		4.24	ns
t <sub>ESBSRC</sub>		2.58		3.49		5.02	ns
t <sub>ESBAWC</sub>		3.88		5.45		8.08	ns
t <sub>ESBSWC</sub>		4.08		5.35		7.48	ns
t <sub>ESBWASU</sub>	1.77		2.49		3.68		ns
t <sub>ESBWAH</sub>	0.00		0.00		0.00		ns
t <sub>ESBWDSU</sub>	1.95		2.74		4.05		ns
t <sub>ESBWDH</sub>	0.00		0.00		0.00		ns
t <sub>ESBRASU</sub>	1.96		2.75		4.07		ns
t <sub>ESBRAH</sub>	0.00		0.00		0.00		ns
t <sub>ESBWESU</sub>	1.80		2.73		4.28		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	0.07		0.48		1.17		ns
t <sub>ESBDAZH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	0.30		0.80		1.64		ns
t <sub>ESBRAADDRSU</sub>	0.37		0.90		1.78		ns
t <sub>ESBDAZCO1</sub>		1.11		1.32		1.67	ns
t <sub>ESBDAZCO2</sub>		2.65		3.73		5.53	ns
t <sub>ESBDD</sub>		3.88		5.45		8.08	ns
t <sub>PD</sub>		1.91		2.69		3.98	ns
t <sub>PTERMSU</sub>	1.04		1.71		2.82		ns
t <sub>PTERMCO</sub>		1.13		1.34		1.69	ns

**Table 51. EP20K30E  $f_{MAX}$  Routing Delays**

Symbol	-1		-2		-3		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>F1-4</sub>		0.24		0.27		0.31	ns
t <sub>F5-20</sub>		1.03		1.14		1.30	ns
t <sub>F20+</sub>		1.42		1.54		1.77	ns

**Table 56. EP20K60E  $f_{MAX}$  ESB Timing Microparameters**

Symbol	-1		-2		-3		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>ESBARC</sub>		1.83		2.57		3.79	ns
t <sub>ESBSRC</sub>		2.46		3.26		4.61	ns
t <sub>ESBAWC</sub>		3.50		4.90		7.23	ns
t <sub>ESBSWC</sub>		3.77		4.90		6.79	ns
t <sub>ESBWASU</sub>	1.59		2.23		3.29		ns
t <sub>ESBWAH</sub>	0.00		0.00		0.00		ns
t <sub>ESBWDSU</sub>	1.75		2.46		3.62		ns
t <sub>ESBWDH</sub>	0.00		0.00		0.00		ns
t <sub>ESBRASU</sub>	1.76		2.47		3.64		ns
t <sub>ESBRAH</sub>	0.00		0.00		0.00		ns
t <sub>ESBWESU</sub>	1.68		2.49		3.87		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	0.08		0.43		1.04		ns
t <sub>ESBDATAH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	0.29		0.72		1.46		ns
t <sub>ESBRAADDRSU</sub>	0.36		0.81		1.58		ns
t <sub>ESBDAACO1</sub>		1.06		1.24		1.55	ns
t <sub>ESBDAACO2</sub>		2.39		3.35		4.94	ns
t <sub>ESBDD</sub>		3.50		4.90		7.23	ns
t <sub>PD</sub>		1.72		2.41		3.56	ns
t <sub>PTERMSU</sub>	0.99		1.56		2.55		ns
t <sub>TERMCO</sub>		1.07		1.26		1.08	ns

Tables 85 through 90 describe  $f_{MAX}$  LE Timing Microparameters,  $f_{MAX}$  ESB Timing Microparameters,  $f_{MAX}$  Routing Delays, Minimum Pulse Width Timing Parameters, External Timing Parameters, and External Bidirectional Timing Parameters for EP20K400E APEX 20KE devices.

**Table 85. EP20K400E  $f_{MAX}$  LE Timing Microparameters**

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>SU</sub>	0.23		0.23		0.23		ns
t <sub>H</sub>	0.23		0.23		0.23		ns
t <sub>CO</sub>		0.25		0.29		0.32	ns
t <sub>LUT</sub>		0.70		0.83		1.01	ns

**Table 94. EP20K600E Minimum Pulse Width Timing Parameters**

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>CH</sub>	2.00		2.50		2.75		ns
t <sub>CL</sub>	2.00		2.50		2.75		ns
t <sub>CLRP</sub>	0.18		0.26		0.34		ns
t <sub>PREP</sub>	0.18		0.26		0.34		ns
t <sub>ESBCH</sub>	2.00		2.50		2.75		ns
t <sub>ESBCL</sub>	2.00		2.50		2.75		ns
t <sub>ESBWP</sub>	1.17		1.68		2.18		ns
t <sub>ESBRP</sub>	0.95		1.35		1.76		ns

**Table 95. EP20K600E External Timing Parameters**

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>INSU</sub>	2.74		2.74		2.87		ns
t <sub>INH</sub>	0.00		0.00		0.00		ns
t <sub>OUTCO</sub>	2.00	5.51	2.00	6.06	2.00	6.61	ns
t <sub>INSUPLL</sub>	1.86		1.96		-		ns
t <sub>INHPLL</sub>	0.00		0.00		-		ns
t <sub>OUTCOPLL</sub>	0.50	2.62	0.50	2.91	-	-	ns

**Table 96. EP20K600E External Bidirectional Timing Parameters**

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>INSUBIDIR</sub>	0.64		0.98		1.08		ns
t <sub>INHBIDIR</sub>	0.00		0.00		0.00		ns
t <sub>OUTCOBIDIR</sub>	2.00	5.51	2.00	6.06	2.00	6.61	ns
t <sub>XZBIDIR</sub>		6.10		6.74		7.10	ns
t <sub>ZXBIDIR</sub>		6.10		6.74		7.10	ns
t <sub>INSUBIDIRPLL</sub>	2.26		2.68		-		ns
t <sub>INHBIDIRPLL</sub>	0.00		0.00		-		ns
t <sub>OUTCOBIDIRPLL</sub>	0.50	2.62	0.50	2.91	-	-	ns
t <sub>XZBIDIRPLL</sub>		3.21		3.59		-	ns
t <sub>ZXBIDIRPLL</sub>		3.21		3.59		-	ns

**Table 99. EP20K1000E  $f_{MAX}$  Routing Delays**

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{F1-4}$		0.27		0.27		0.27	ns
$t_{F5-20}$		1.45		1.63		1.75	ns
$t_{F20+}$		4.15		4.33		4.97	ns

**Table 100. EP20K1000E Minimum Pulse Width Timing Parameters**

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{CH}$	1.25		1.43		1.67		ns
$t_{CL}$	1.25		1.43		1.67		ns
$t_{CLRP}$	0.20		0.20		0.20		ns
$t_{PREP}$	0.20		0.20		0.20		ns
$t_{ESBCH}$	1.25		1.43		1.67		ns
$t_{ESBCL}$	1.25		1.43		1.67		ns
$t_{ESBWP}$	1.28		1.51		1.65		ns
$t_{ESBRP}$	1.11		1.29		1.41		ns

**Table 101. EP20K1000E External Timing Parameters**

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{INSU}$	2.70		2.84		2.97		ns
$t_{INH}$	0.00		0.00		0.00		ns
$t_{OUTCO}$	2.00	5.75	2.00	6.33	2.00	6.90	ns
$t_{INSUPLL}$	1.64		2.09		-		ns
$t_{INHPLL}$	0.00		0.00		-		ns
$t_{OUTCOPLL}$	0.50	2.25	0.50	2.99	-	-	ns